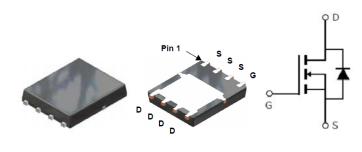


Main Product Characteristics:

V _{DSS}	30V
R _{DS} (on)	1.9mΩ (typ.)
I _D	130A



PPAK5*6-8L

Schematic diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute max Rating:

Symbol	Parameter	Max.	Units	
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V①	130		
I _D @ TC = 100°C	Continuous Drain Current, V _{GS} @ 10V①	100	A	
I _{DM}	Pulsed Drain Current2	327		
P _D @TC = 25°C	Power Dissipation③	90	W	
V _{DS}	Drain-Source Voltage	30	V	
V _{GS}	Gate-to-Source Voltage	± 20	V	
E _{AS}	Single Pulse Avalanche Energy 2	152	mJ	
I _{AR}	Avalanche Current @ L=0.3mH2	55	А	
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to + 150	°C	



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
R _{θJC}	Junction-to-case③	_	2	°C/W
R _{0JA}	Junction-to-ambient (t $\leq 10s$) (4)	_	50	°C/W

$\label{eq:constraint} \textbf{Electrical Characterizes} @ \texttt{T}_{A} \texttt{=} 25^{\circ} \texttt{C} \text{ unless otherwise specified}$

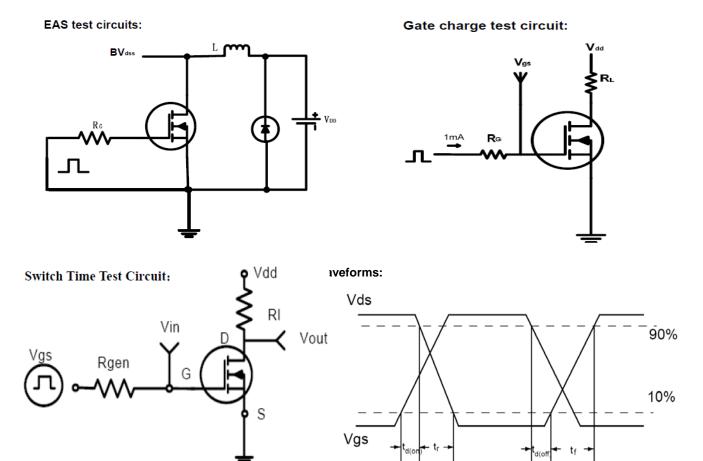
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	30	—	—	V	V _{GS} = 0V, ID = 250µA
	Static Drain-to-Source on-resistance	_	1.9	2.4		V _{GS} =10V,I _D = 30A
R _{DS(on)}	Static Drain-to-Source on-resistance	_	2.5	3.3	mΩ	V _{GS} =4.5V,I _D = 15A
D	Static Drain-to-Source on-resistance	_	4	5	mΩ	V _{GS} =4.5V,I _D = 16A
R _{DS(on)}	Static Drain-to-Source on-resistance	_	5	—		T」= 125℃
Vacuus	Cata threshold voltage	1	1.6	2.8	v	$V_{DS} = V_{GS}, I_D = 250 \mu A$
V _{GS(th)}	Gate threshold voltage	_	1.0	—	v	T _J = 125℃
1	Drain to Source lookage ourrent	_	—	1		$V_{DS} = 24V, V_{GS} = 0V$
I _{DSS} Dr	Drain-to-Source leakage current	_	—	50	μA	T _J = 125°C
I _{GSS} Gat	Gate-to-Source forward leakage	_	—	100	nA	V _{GS} =20V
		_	—	-100		V _{GS} = -20V
Qg	Total gate charge	_	40	—		V _{DS} =15V,
Q _{gs}	Gate-to-Source charge	_	6	—	nC	I _D =24A,
Q_{gd}	Gate-to-Drain("Miller") charge	_	19	—		V _{GS} =4.5V
t _{d(on)}	Turn-on delay time	_	20	—		
tr	Rise time	—	32	—		V _{GS} =10V, VDS=15V,
$t_{d(off)}$	Turn-Off delay time	_	75	—	ns	R_{GEN} =1 Ω , I_{D} =1A
t _f	Fall time		28	—		
C _{iss}	Input capacitance		4800	—		V _{GS} = 0V
Coss	Output capacitance	_	735	_	pF	V _{DS} = 25V
C _{rss}	Reverse transfer capacitance	_	420			f = 1MHz

Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current		Ι	130	А	MOSFET symbol
	(Body Diode)					showing the $_{G}(+)$
I _{SM}	Pulsed Source Current		_	327	А	integral reverse
	(Body Diode)	_				p-n junction diode.
V _{SD}	Diode Forward Voltage	_	0.85	1.3	V	I _S =50A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	49	_	ns	$T_J = 25^{\circ}C, I_F = 1A,$
Q _{rr}	Reverse Recovery Charge	_	18		nC	di/dt = 100A/µs



Test circuits and Waveforms



Notes:

- ①The maximum current rating is limited by bond-wires.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- (4) The value of $R_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C
- (5) These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175°C.



SSF3960J7-HF

Typical electrical characteristics

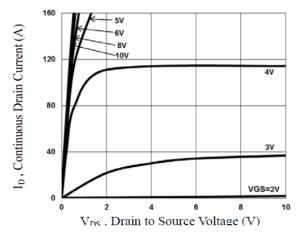


Figure 1: Typical Output Characteristics

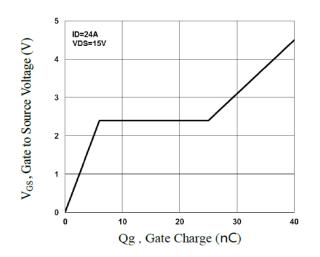
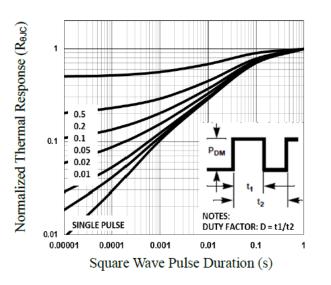


Figure 3: Gate-Charge Characteristics





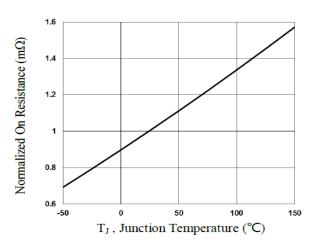
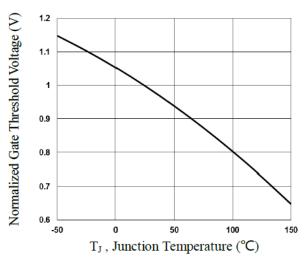
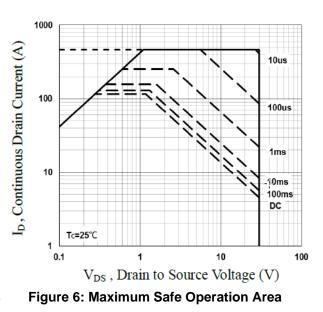


Figure 2: Normalized RDSON vs. TJ



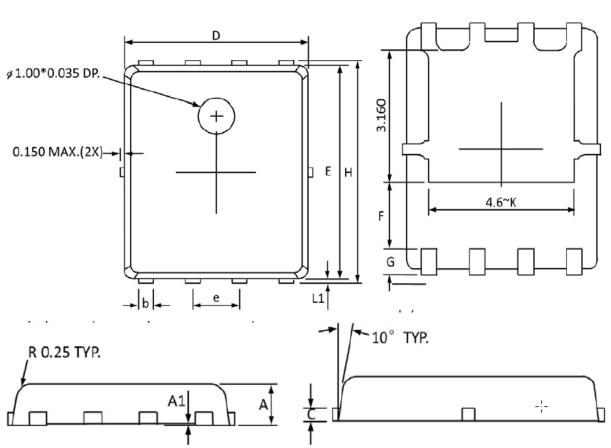




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Mechanical Data:



Symbol	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	0.800	1.000	0.032	0.039	
A1	0.000	0.005	0.000	0.000	
b	0.350	0.490	0.014	0.019	
С	0.254	4 Ref	0.254 Ref		
D	4.900	5.100	0.193	0.200	
E	5.700	5.900	0.225	0.232	
e	1.27 BSC		1.27 BSC		
F	1.600 Ref		1.600 Ref		
G	0.600 Ref		0.60	0 Ref	
н	5.950	6.200	0.235	0.244	
L1	0.100	0.180	0.004	0.007	
К	3.20	0 Ref	3.20	0 Ref	

PPAK5x6 PACKAGE INFORMATION

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Ordering and Marking Information

Device Marking: SSF3960J7-HF Package (Available) PPAK 5*6-8L Operating Temperature Range C : -55 to 150 °C

Devices per Unit

Package Type	Units/ Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
PPAK5*6	5000	1	5000	5	25000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _J =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	100% of Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			



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